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Jacqueline J Garner

972-278-9775

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: S. Papa Rao
Serial No.: 09/679,796
Filing Date: 10/05/2000
Customer No.: 23494

Art Unit: 2625
Examiner: Bayat, A.
Docket No.: TI-29098
Conf. No.: 8657

Title: X-RAY DEFECT DETECTION IN INTEGRATED CIRCUIT
METALLIZATION

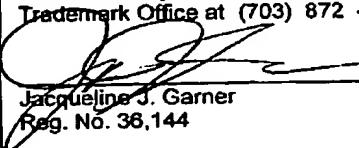
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AMENDMENT UNDER 37 CFR 1.111

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that the following papers are being
transmitted by facsimile to the U.S. Patent and
Trademark Office at (703) 872 - 9306 on 7/6/2004.


Jacqueline J. Garner
Reg. No. 36,144

Dear Sir:

The following amendments and remarks are offered in response to the Examiner's Office Action dated 02/03/2004. They are respectfully submitted as a full and complete response to that Action.

Please amend the above-referenced application as follows:

There are no Amendments to the Specification.

Amendments to the Claims are reflected in the listing of claims that begin on page 2 of this paper.

There are no Amendments to the Drawings.

The Remarks begin on page 7.